



# P-Channel 30 V (D-S) MOSFET

MOSFET PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$R_{DS(on)}\left(\Omega\right)$ Max.	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)		
	0.042 at V <sub>GS</sub> = - 10 V	- 5			
- 30	0.054 at V <sub>GS</sub> = - 6 V	- 4.4	6.9 nC		
	0.068 at V <sub>GS</sub> = - 4.5 V	- 3.9			

#### **FEATURES**

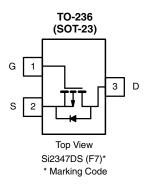
- TrenchFET® Power MOSFET
- 100 % R<sub>g</sub> Tested
- Material categorization: For definitions of compliance please see www.vishav.com/doc?99912



HALOGEN FREE

## **APPLICATIONS**

- Load Switch
- Notebook Adaptor Switch
- DC/DC Converter
- **Power Management**



Ordering Information: Si2347DS-T1-GE3 (Lead (Pb)-free and Halogen-free)

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	$V_{DS}$	- 30	V	
Gate-Source Voltage	$V_{GS}$	± 20	<u> </u>	
	T <sub>C</sub> = 25 °C		- 5	
Continuous Drain Current (T <sub>1</sub> = 150 °C)	T <sub>C</sub> = 70 °C	l .	- 4	
Continuous Brain Current (1) = 100 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	- 3.8 <sup>b,c</sup>	
	T <sub>A</sub> = 70 °C		- 3 <sup>b,c</sup>	A
Pulsed Drain Current (t = 300 μs)	I <sub>DM</sub>	- 20		
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	l <sub>o</sub>	- 1.4	
Continuous Source-Diain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	- 0.63 <sup>b,c</sup>	
	T <sub>C</sub> = 25 °C		1.7	
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	$P_{D}$	1.1	w
Maximum Fower Dissipation	T <sub>A</sub> = 25 °C	' <sup>D</sup>	1.20 <sup>b, c</sup>	
	T <sub>A</sub> = 70 °C		0.6 <sup>b, c</sup>	
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>b, d</sup>	≤ 5 s	$R_{thJA}$	100	130	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	$R_{thJF}$	60	75	O/ <b>VV</b>	

#### Notes:

- a. Based on  $T_C$  = 25 °C.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 5 s.
- d. Maximum under steady state conditions is 175 °C/W.



Parameter   Symbol   Test Conditions   Min.   Typ.   Max.   Unit Static	MOSFET SPECIFICATIONS (T <sub>J</sub> = 25 °C, unless otherwise noted)							
Drain-Source Breakdown Voltage   V <sub>DS</sub>   V <sub>DS</sub> = 0 V, I <sub>D</sub> = -250 μA   -30   V   V   V   V <sub>DS</sub> Temperature Coefficient   AV <sub>DS</sub> (III)   I <sub>D</sub> = -250 μA   -30   mV/°C   MV/°C   MV <sub>DS</sub> (III)   I <sub>D</sub> = -250 μA   -1   -2.5   V   MV/°C   MV/°C   MV <sub>DS</sub> (III)   I <sub>D</sub> = -250 μA   -1   -2.5   V   MV/°C   MV <sub>DS</sub> (III)   I <sub>D</sub> = -250 μA   -1   -2.5   V   MV/°C   MV <sub>DS</sub> (III)   I <sub>D</sub> = -250 μA   -1   -2.5   V   MV/°C   MV <sub>DS</sub> (III)   I <sub>D</sub> = -250 μA   -1   -2.5   V   MV/°C   MV <sub>DS</sub> (III)   I <sub>D</sub> = -250 μA   -1   -2.5   V   MV/°C   MV <sub>DS</sub> (III)   I <sub>D</sub> = -250 μA   -1   -2.5   V   MV/°C   MV/°	Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Vos Temperature Coefficient	Static	Static						
Vosition	Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V, } I_{D} = -250 \mu\text{A}$	- 30			V	
Vaskin   temperature Coefficient   AVGs(m)   V_DS = V_GS.   b = -250 μA   -1   -2.5   V	V <sub>DS</sub> Temperature Coefficient		L = 250 uA		- 25		mV/°C	
Gate-Source Leakage	V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	,		3.9			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = -250 \mu A$	- 1		- 2.5	V	
Description	Gate-Source Leakage	I <sub>GSS</sub>				± 100	nA	
On-State Drain Current®         ID <sub>(on)</sub> V <sub>DS</sub> ≤ - 5 V, V <sub>GS</sub> = -10 V, I <sub>D</sub> = 5 °C         -10         A           Drain-Source On-State Resistance®         R <sub>DS(on)</sub> V <sub>GS</sub> = -10 V, I <sub>D</sub> = -3.8 A         0.033         0.042         Ω           Forward Transconductance®         g <sub>Is</sub> V <sub>DS</sub> = -5 V, I <sub>D</sub> = -3.8 A         0.050         0.068         0.050         0.068           Forward Transconductance®         g <sub>Is</sub> V <sub>DS</sub> = -5 V, I <sub>D</sub> = -3.8 A         10         S         S           Dynamic*         Duptut Capacitance         C <sub>Iss</sub> V <sub>DS</sub> = -5 V, I <sub>D</sub> = -3.8 A         10         S         S           Reverse Transfer Capacitance         C <sub>Iss</sub> V <sub>DS</sub> = -15 V, V <sub>GS</sub> = 0 V, f = 1 MHz         93         pF         pF           Total Gate Charge         Q <sub>g</sub> V <sub>DS</sub> = -15 V, V <sub>GS</sub> = -10 V, I <sub>D</sub> = -5 A         14.5         22         nC           Gate-Drain Charge         Q <sub>g</sub> V <sub>DS</sub> = -15 V, V <sub>QS</sub> = -4.5 V, I <sub>D</sub> = -5 A         14.5         22         nC           Gate-Besistance         R <sub>g</sub> f = 1 MHz         1.7         8.3         17         Ω           Turn-Oft Delay Time         I <sub>t</sub> (cin)         V <sub>DD</sub> = -15 V, R <sub>L</sub> = 5 Ω         6         12         ns         ns           Fall Time         <	Zero Gate Voltage Drain Current	lpaa	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}$			- 1	μΑ	
Drain-Source On-State Resistance   Position   Positi	Zero date voltage Drain Gurrent	פטי	$V_{DS}$ = - 30 V, $V_{GS}$ = 0 V, $T_J$ = 55 °C			- 10		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le$ - 5 V, $V_{GS}$ = - 10 V	- 20			Α	
Vos = -4.5 V, Ip = -3 A   0.050   0.068			V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 3.8 A		0.033	0.042	Ω	
Promain   Pro	Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 6 V, I <sub>D</sub> = - 3.3 A		0.041	0.054		
Input Capacitance			$V_{GS} = -4.5 \text{ V}, I_D = -3 \text{ A}$		0.050	0.068		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 5 V, I <sub>D</sub> = - 3.8 A		10		S	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Dynamic <sup>b</sup>					<b>'</b>		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Input Capacitance	C <sub>iss</sub>			705			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Output Capacitance		$V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		93		pF	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Reverse Transfer Capacitance				73			
Gate-Source Charge $Q_{gs}$ $V_{DS} = -15$ V, $V_{GS} = -4.5$ V, $I_{D} = -5$ A         6.9         10.4         nC           Gate-Drain Charge $Q_{gd}$ 2.3         -2.3         -2.1	T. 10 . 0		V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 5 A		14.5	22		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Total Gate Charge	$Q_{g}$			6.9	10.4		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Gate-Source Charge	$Q_{gs}$	$V_{DS} = -15 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -5 \text{ A}$		2.3		nC	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Gate-Drain Charge				2.1			
Rise Time $t_r$ $V_{DD} = -15 \text{ V}, R_L = 5 \Omega$ 6         12           Turn-Off Delay Time $t_d$ 19         29           Fall Time         9         18           Turn-On Delay Time $t_d$ 9         18           Turn-Off Delay Time $t_d$ $V_{DD} = -15 \text{ V}, R_L = 5 \Omega$ 9         18           Turn-Off Delay Time $t_d$ $V_{DD} = -15 \text{ V}, R_L = 5 \Omega$ 9         18         27           Fall Time $t_f$ $I_D = -3 \text{ A}, V_{GEN} = -6 \text{ V}, R_G = 1 \Omega$ 18         27         14           Drain-Source Body Diode Characteristics           Continuous Source-Drain Diode Current $I_S$ $I_S = -3 \text{ C}$ $I_S = -3 \text{ A}$ $I_S = -3  $	Gate Resistance		f = 1 MHz	1.7	8.3	17	Ω	
Rise Time $t_r$ $V_{DD} = -15 \text{ V}, R_L = 5 \Omega$ 6         12           Turn-Off Delay Time $t_d$ 19         29           Fall Time         9         18           Turn-On Delay Time $t_d$ 9         18           Turn-Off Delay Time $t_d$ $V_{DD} = -15 \text{ V}, R_L = 5 \Omega$ 9         18           Turn-Off Delay Time $t_d$ $V_{DD} = -15 \text{ V}, R_L = 5 \Omega$ 9         18         27           Fall Time $t_f$ $I_D = -3 \text{ A}, V_{GEN} = -6 \text{ V}, R_G = 1 \Omega$ 18         27         14           Drain-Source Body Diode Characteristics           Continuous Source-Drain Diode Current $I_S$ $I_S = -3 \text{ C}$ $I_S = -3 \text{ A}$ $I_S = -3  $	Turn-On Delay Time	t <sub>d(on)</sub>			6	12		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Rise Time		$V_{DD}$ = - 15 V, $R_L$ = 5 $\Omega$		6	12	ns	
	Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D$ = - 3 A, $V_{GEN}$ = - 10 V, $R_G$ = 1 $\Omega$		19	29		
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	Fall Time				9	18		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Turn-On Delay Time	t <sub>d(on)</sub>			10	20		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Rise Time	t <sub>r</sub>	$V_{DD}$ = - 15 V, $R_L$ = 5 $\Omega$		9	18	- ns	
	Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D$ = - 3 A, $V_{GEN}$ = - 6 V, $R_G$ = 1 $\Omega$		18	27		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Fall Time	t <sub>f</sub>			7	14		
Pulse Diode Forward Current <sup>a</sup> $I_{SM}$ $-20$ Body Diode Voltage $V_{SD}$ $I_S = -3$ A $-0.8$ $-1.2$ $V$ Body Diode Reverse Recovery Time $t_{rr}$ $13$ $20$ $ns$ Body Diode Reverse Recovery Charge $Q_{rr}$ Reverse Recovery Fall Time $t_a$ $I_F = -3$ A, $dI/dt = 100$ A/ $\mu$ s, $T_J = 25$ °C $T_{rot}$ $T_{rot}$ $T_{rot}$	Drain-Source Body Diode Characteristics							
Pulse Diode Forward Current <sup>a</sup> Body Diode Voltage  V <sub>SD</sub> $V_{SD}$ $V_{SD}$ $V_{SD}$ $V_{SD}$ Body Diode Reverse Recovery Time $V_{rr}$ Body Diode Reverse Recovery Charge $V_{rr}$ Reverse Recovery Fall Time $V_{SD}$	Continuous Source-Drain Diode Current	I <sub>S</sub>	$T_C = 25  ^{\circ}C$			- 1.4	۸	
Body Diode Reverse Recovery Time $t_{rr}$ Body Diode Reverse Recovery Charge $Q_{rr}$ Reverse Recovery Fall Time $t_a$ $I_F = -3 \text{ A, dl/dt} = 100 \text{ A/µs, T}_J = 25 \text{ °C}$ $7$ $ns$	Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				- 20	^	
Body Diode Reverse Recovery Charge $Q_{rr}$ $I_F = -3 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$ $T$	Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = - 3 A		- 0.8	- 1.2	V	
Reverse Recovery Fall Time $t_a$ $I_F = -3 \text{ A}$ , $dI/dt = 100 \text{ A/µs}$ , $I_J = 25 \text{ °C}$ 7	Body Diode Reverse Recovery Time	t <sub>rr</sub>			13	20	ns	
Reverse Recovery Fall Time t <sub>a</sub> 7	Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	L 2 A dl/dt _ 100 A/v2 T _ 25 °C		5	10	nC	
Reverse Recovery Rise Time t <sub>b</sub> 6	Reverse Recovery Fall Time	t <sub>a</sub>	$I_{\rm F} = -3$ A, dI/dt = 100 A/ $\mu$ s, $I_{\rm LI} = 25$ °C		7			
	Reverse Recovery Rise Time	t <sub>b</sub>			6		- ns	

## Notes:

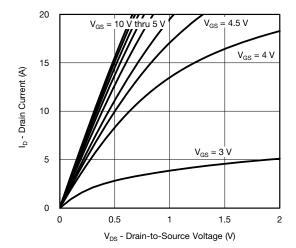
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$ 

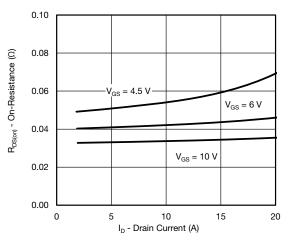
b. Guaranteed by design, not subject to production testing.



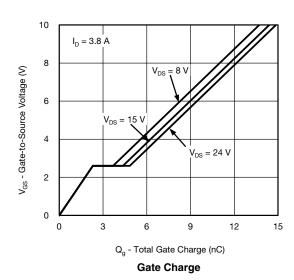
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

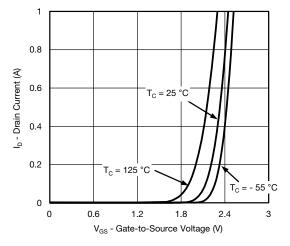


## **Output Characteristics**

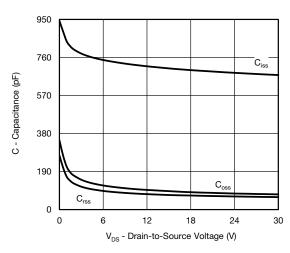


## On-Resistance vs. Drain Current and Gate Voltage

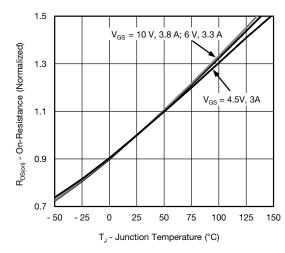




#### **Transfer Characteristics**

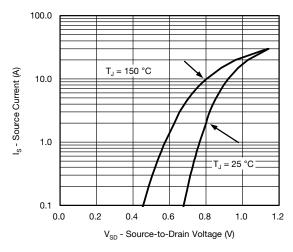


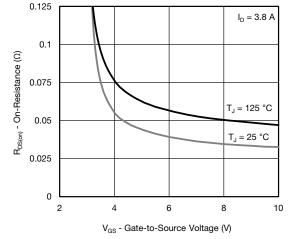
#### Capacitance



On-Resistance vs. Junction Temperature

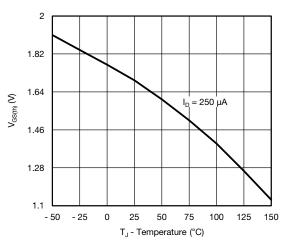
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

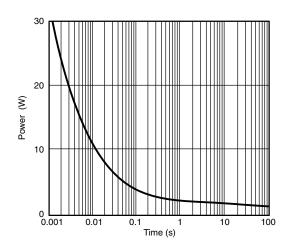




Source-Drain Diode Forward Voltage

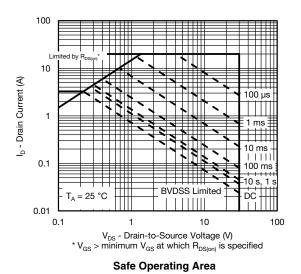
On-Resistance vs. Gate-to-Source Voltage





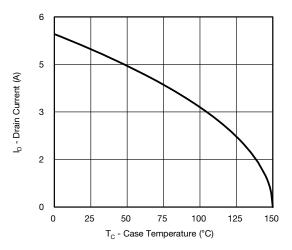
**Threshold Voltage** 

Single Pulse Power

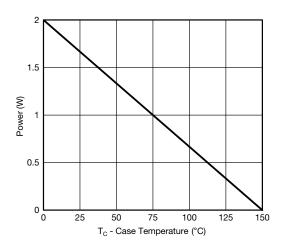




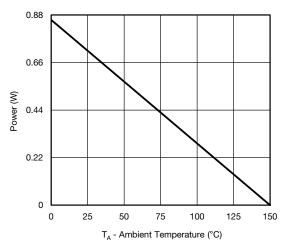
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



### **Current Derating\***





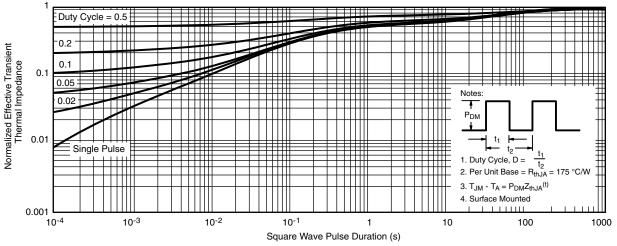


Power, Junction-to-Ambient

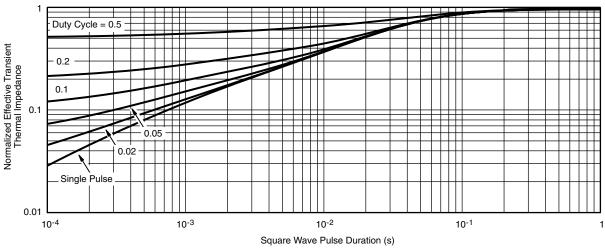
<sup>\*</sup> The power dissipation PD is based on TJ(max.) = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heats inking is used. It is used to determine the current rating, when this rating falls below the package limit.



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?62827.

## SOT-23 (TO-236): 3-LEAD







Dim	MILLI	METERS	INCHES			
	Min	Max	Min	Max		
Α	0.89	1.12	0.035	0.044		
A <sub>1</sub>	0.01	0.10	0.0004	0.004		
A <sub>2</sub>	0.88	1.02	0.0346	0.040		
b	0.35	0.50	0.014	0.020		
С	0.085	0.18	0.003	0.007		
D	2.80	3.04	0.110	0.120		
E	2.10	2.64	0.083	0.104		
E <sub>1</sub>	1.20	1.40	0.047	0.055		
е	0.95 BSC		0.037	0.0374 Ref		
e <sub>1</sub>	1.90 BSC		0.074	0.0748 Ref		
L	0.40	0.60	0.016	0.024		
L <sub>1</sub>	0.64 Ref		0.025	5 Ref		
S	0.50 Ref		0.020	) Ref		
q	3°	8°	3°	8°		
FCN: S-03946-Rev K 09-	lul-01	•				

ECN: S-03946-Rev. K, 09-Jul-01

DWG: 5479

Document Number: 71196 www.vishay.com 09-Jul-01





# **Mounting LITTLE FOOT® SOT-23 Power MOSFETs**

Wharton McDaniel

Surface-mounted LITTLE FOOT power MOSFETs use integrated circuit and small-signal packages which have been been modified to provide the heat transfer capabilities required by power devices. Leadframe materials and design, molding compounds, and die attach materials have been changed, while the footprint of the packages remains the same.

See Application Note 826, Recommended Minimum Pad Patterns With Outline Drawing Access for Vishay Siliconix MOSFETs, (http://www.vishay.com/doc?72286), for the basis of the pad design for a LITTLE FOOT SOT-23 power MOSFET footprint. In converting this footprint to the pad set for a power device, designers must make two connections: an electrical connection and a thermal connection, to draw heat away from the package.

The electrical connections for the SOT-23 are very simple. Pin 1 is the gate, pin 2 is the source, and pin 3 is the drain. As in the other LITTLE FOOT packages, the drain pin serves the additional function of providing the thermal connection from the package to the PC board. The total cross section of a copper trace connected to the drain may be adequate to carry the current required for the application, but it may be inadequate thermally. Also, heat spreads in a circular fashion from the heat source. In this case the drain pin is the heat source when looking at heat spread on the PC board.

Figure 1 shows the footprint with copper spreading for the SOT-23 package. This pattern shows the starting point for utilizing the board area available for the heat spreading copper. To create this pattern, a plane of copper overlies the drain pin and provides planar copper to draw heat from the drain lead and start the process of spreading the heat so it can be dissipated into the ambient air. This pattern uses all the available area underneath the body for this purpose.



FIGURE 1. Footprint With Copper Spreading

Since surface-mounted packages are small, and reflow soldering is the most common way in which these are affixed to the PC board, "thermal" connections from the planar copper to the pads have not been used. Even if additional planar copper area is used, there should be no problems in the soldering process. The actual solder connections are defined by the solder mask openings. By combining the basic footprint with the copper plane on the drain pins, the solder mask generation occurs automatically.

A final item to keep in mind is the width of the power traces. The absolute minimum power trace width must be determined by the amount of current it has to carry. For thermal reasons, this minimum width should be at least 0.020 inches. The use of wide traces connected to the drain plane provides a low-impedance path for heat to move away from the device.

Document Number: 70739

26-Nov-03



## **RECOMMENDED MINIMUM PADS FOR SOT-23**



Recommended Minimum Pads Dimensions in Inches/(mm)

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APPLICATION NOTE



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Revision: 13-Jun-16 1 Document Number: 91000

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